

# Thermal Current Sensor based on Metal Coated Hi-Bi Fiber Loop Mirror

B. V. Marques, O. Frazão, S. Mendonça, J. Perez, M. B. Marques, S. F. Santos, J. M. Baptista

**Abstract**—In this work we report a thermal current sensor based on a metal coated Hi-Bi fiber loop mirror. This sensor quantifies the current through the measurement of the temperature which varies accordingly with the magnitude of the electric current. The temperature change is analyzed through the variation of the phase shift of a Hi-Bi fiber loop mirror.

**Index Terms**—Fiber Optic Sensors, Optical Current Sensor, Hi-Bi Fiber Loop Mirror, Sagnac Interferometer

## I. INTRODUCTION

IN very particular industrial environments, where electric current based systems are considered potentially dangerous for human physical integrity or where there is highly contaminated electromagnetic interference, optical device sensors are preferred instead of the traditional electric ones, normally based on the Faraday or other magnetic effects [1-3]. Traditionally, the optical current sensors based on the Faraday effect are built under a silica fiber coil around the current conductor, but this approach has some disadvantages.

The sensor presented in this article is based on a phase shift of the optical signal caused by thermal effects of the metal current conductor. It is demonstrated, experimentally, one way to measure electric current due to the respective variation of the conductor's temperature. The apparatus that supports the sensor head is a fiber loop mirror (FLM) incorporating a segment of high-birefringence (Hi-Bi) fiber, coated with a thin metallic layer in order to allow an homogeneous thermal coupling between the fiber and the electric current conductor.

## II. PRINCIPLES

It can be seen in the literature that a certain variation in the temperature  $\Delta T$ , implies a well defined variation in the spectral width of the interference pattern fringes of a FLM that incorporates the Hi-Bi fiber [4]. On the other hand, it is possible to relate these parameters, knowing the fiber thermal expansion and thermal-optic coefficients,  $C_{T1}$  and  $C_{T2}$ , respectively. With well determined fiber parameters like

length ( $l$ ), birefringence index ( $n_e - n_o$ ) and operation wavelength ( $\lambda_p$ ), it is possible to establish the following relation given by Equation 1:

$$\Delta\lambda = \frac{1}{k_p} [l \times C_{T2} \times \Delta T + (n_e - n_o) \times C_{T1} \times \Delta T] \quad (1)$$

where, constant  $k_p$  is defined by Equation 2:

$$k_p = \frac{l \times (n_e - n_o)}{\lambda_p} \quad (2)$$

Other expression needed is the one relating  $\Delta T$  with the direct variation of the electric current ( $I$ ). This last one, involves variables like de conductor's electric resistance ( $R_0$ ), the environment temperature ( $T_a$ ), the conductor self physical characteristics (length, thermal expansion coefficient, electric resistivity, conductor's cross section) and some adjustment constants ( $k$  and  $\alpha$ ). Therefore, it is shown in Equation 3, the relation between the temperature and the current crossing the material.

$$\Delta T = T - T_a = \frac{-R_0 \times I^2}{R_0 \times \alpha \times l^2 - k} \quad (3)$$

## III. FIBER METAL COATING PROCESS

In order to improve the stability of the measurement, an homogeneous thermal coupling between the fiber and the electric current conductor was achieved by applying a metal coating to the fiber. The Hi-Bi fiber segment was covered with a 300 nm Nickel-Cromium (80/20) layer. This layer was deposited at room temperature, using an Edwards 306 evaporator with a vacuum condition of  $6 \times 10^{-6}$  mbar and a constant current of  $\approx 20$  A in order to achieve a deposition rate of 0.5 nm/s.

## IV. EXPERIMENTAL DESCRIPTION

Figure 1 presents the experimental setup which consists of an optical broadband source, a 3 dB coupler, an optical fiber loop mirror including the Hi-Bi metallic coated fiber segment attached to the current conductor, a thermal clamp in order to control de conductor's temperature and the optical spectrum analyzer (OSA). The fiber was fixed to the current conductor with epoxy glue. The Hi-Bi fiber loop mirror [4-5] acts as a band pass filter for the input signal from the source. The difference between the optical path, introduced by the Hi-Bi

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fiber segment, for the two counter propagating waves coming from the coupler as they transverse the loop results in constructive and destructive interference pattern which can be seen in the filter response (Figure 2).

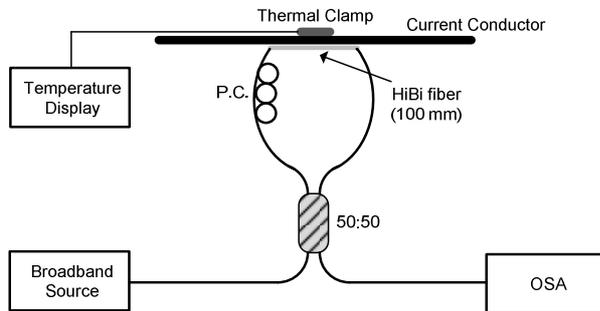


Figure 1 – Experimental setup of the FLM

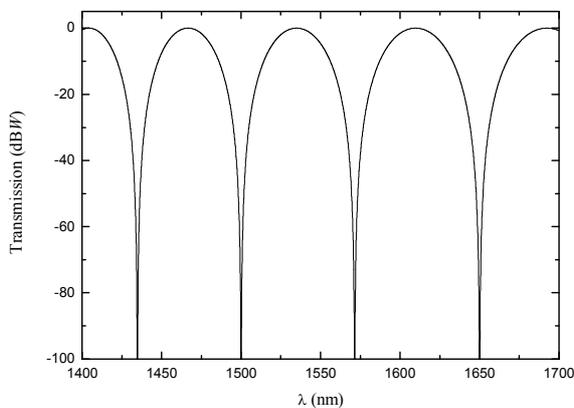


Figure 2 - Band pass filter spectral behavior of Panda fiber segment.

The experience was made with a 100 mm ( $l$ ) PANDA Hi-Bi fiber segment with a birefringence index of  $3.3 \times 10^{-4}$  and a fringe spectral width ( $\Delta\lambda$ ) of approximately 78 nm was achieved. This result can be confirmed through  $\Delta\lambda = \lambda^2 / \beta l$ , where  $\lambda$  represents the central wavelength of the source and  $\beta$  the index of birefringence ( $n_e - n_o$ ) of PANDA's fiber segment.

The copper current conductor used had the intrinsic values of  $5 \times 10^{-7}/^\circ\text{C}$  and  $-3.47 \times 10^{-7}/^\circ\text{C}$  for  $C_{T1}$  and  $C_{T2}$ , respectively, and it was crossed by an electric current in the range of 100-700 A. For each step of input current from the electrical source, the conductor's temperature was measured with a conventional thermocouple and the wavelength variation through the OSA.

The two measurements can be seen in Figure 3. As expected, and in accordance to equation 3, a non linear relationship between temperature and applied current was obtained. On the other hand the wavelength response has a similar behavior but with opposite sign. This is due to the thermal response of the optical fiber.

The sensitivity of the wavelength versus the current is aprox.  $-0.046 \text{ nm/A}$  for the low current (0-300 A). For high current (300-700 A) the sensitivity is aprox.  $-0.146 \text{ nm/A}$ .

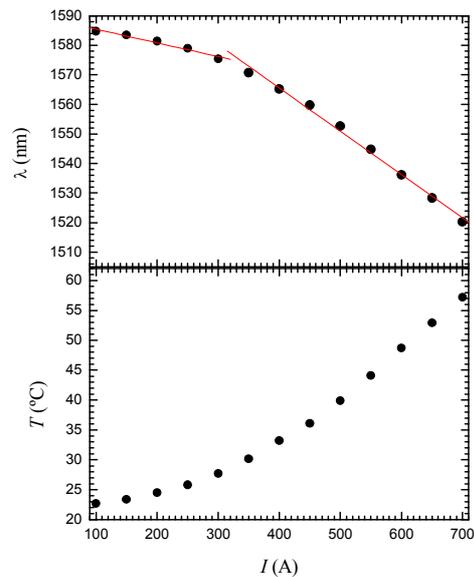


Figure 3 – Conductor's temperature and wavelength responses with variation of current

## V. CONCLUSION

A current sensor based in the Hi-Bi fiber loop mirror was demonstrated with a sensitivity of  $-1.73 \text{ nm}/^\circ\text{C}$ . Due to nonlinear response between current versus wavelength, the current sensitivity can be divided in two regions. For low current the sensitivity is  $-0.046 \text{ nm/A}$  and for high current the sensitivity is three orders of magnitude higher ( $-0.146 \text{ nm/A}$ ). The use of a fiber with metal coating allows homogeneous thermal coupling between the fiber and the electric current conductor, improving the stability of the measurement. This sensor measures the true *rms* current value and can be a simple alternative solution compared to the traditional optical fiber current sensors.

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